



JadePix-3束流望远镜 研究进展和近期测试结果

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- ► JadePix-3芯片介绍
- ► JadePix-3束流望远镜研究进程
- ▶ 近期束流测试结果



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芯片基本功能测试: 阈值/噪声/功耗/...









宇宙线测试 多芯片同步读出系统

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第一次束流测试 Nov. 2022@BSRF 集成离线分析分析软件Corryvreckan

第二次束流测试 Dec. 2022@ 首次得到望远镜空间分辨以及JadePix-3空间分辨





第三次束流测试 April 2023@DESY 阈值扫描/Cluster Size/Spatial resolution/Efficiency/... More analysis in progress





Fig.1 Roadmap of silicon pixel sensor for vertex detector
JadePix-3是CEPC顶点探测器原型之一。
设计目标是高分辨率、低功耗和快速读出。
采用TowerJazz 180nm CMOS技术生产。
设计了4个部分来研究不同的模拟前端和数字电路。(贝芯片面积: 10.4mm(row)×6.1mm(col)
像素阵列: 512(row)×192(col)
最小像素尺寸: 16um×23.11um

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/	
扇区,	可在行方向上扩

(见表1)	I a	
	Sector	
	0	

Tabel. 1 The matrix design of JadePix-3

Sector	Diode	Analog	Digital	Pixel Siz
0	2+2 um	FE_VO	DGT_V0	16 x 26 u
1	2+2 um	FE_VO	DGT_V1	16 x 26 u
2	2+2 um	FE_VO	DGT_V2	16 x 23.11
3	2+2 um	FE_V1	DGT_VO	16 x 26 u





Single Sensor Test

- ●测试方法: 电脉冲测试, 红外线激光束测试, 放射源(90Sr)测试。 ●测试结果摘要:
 - ▶最小阈值: 90e⁻ 140e⁻
 - ▶噪声:低于1×10⁻¹⁰/帧/像素
 - ▶功耗: 127 mW
 - ▶空间分辨率:达到3um(红外线激光束测试)

 Publication: Design and Characterization of the JadePix-3 CMOS pixel sensor https://doi.org/10.1016/j.nima.2022.167967



Fig.1 单芯片测试系统

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Fig.2 单芯片测试系统@CCNU

● 基于分布式控制系统框架IPBus来开发单芯片测试系统,IPbus具有扩展性,可以方便扩展到未来的多芯片读出



Fig.3 红外激光测试平台



束流望远镜研究

- ▶ 设计通用多芯片同步读出系统,为了后续芯片验证做准备(JadePix-4/CPV4-3D)
- ▶ 掌握束流望远镜离线分析算法(径迹重建)
- ▶ 芯片设计迭代



Fig.1 3层束流望远镜原型

测试捕捉了几十条宇宙线,验证了多芯 片同步读出系统设计

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Fig2. 北京同步辐射首次束流测试

捕捉到15000条轨迹(0.1Hz/cm2) Corryvreckan首次被用于离线数据分析







设计了稳定、易安装的望远镜保护框架 最多可安装5层望远镜系统

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Side view



Good for transportation





束流测试@DESYTB21



- The electron or positron beams are converted bremsstrahlung beams from carbon fibre targets in the electron-positron synchrotron DESY II.
- up to 1000 particles per cm² and energies from 1 to 6 GeV, an energy spread of ~5% and a divergence of ~1 mrad.
- 5 层MIMOSA26束流望远镜
- 6层TaichuPix-3束流望远镜
- 4层JadePix-3束流望远镜
- 大部分实验时间束流能量为4GeV

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● 每层芯片噪声像素2-3个



尺寸的影响

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plane1 [41, 150] 1.0 plane1 [177, 259] 1.0 plane2 [38, 4] 1.0 plane2 [125, 183] 1.0 plane3 [70, 145] 1.0 plane3 [87, 343] 1.0 plane3 [100, 404] 1.0

The region of interest (**ROI**)

为了降低数据分析的复杂性,选择Sector 1作为初步数据分析的区域,可以屏蔽Sector边界和Sector 2的不同像素





通过片内DAC调节阈值电流(ITHR),测试范围460pA-640pA,等效阈值电荷~200e--~250e-

ITHR vs Cluster Size



~200e-

~250e-

随着ITHR的增加(电荷阈值增加): Cluster Size大小从3.6降至2.8 (Plane 0/2/3



Threshold







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$$\frac{\sum_{i}^{N} z_i^2}{z_i^2 - (\sum_{i}^{N} z_i)^2}$$

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$Total \ Efficiency = \frac{Numb}{m}$



Number of Tracks which meet criteria

Number of Total Tracks

Test Setup at DESY TB21

- The electron or positron beams are converted bremsstrahlung beams from carbon fibre targets in the electron-positron synchrotron DESY II.
- up to 1000 particles per cm² and energies from 1 to 6 GeV, an energy spread of ~5% and a divergence of ~1 mrad.
- 5 层MIMOSA26束流望远镜
- TaichuPix-3顶点探测器原型
- 5层JadePix-3束流望远镜
- 大部分实验时间束流能量为5GeV-6GeV

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Test Setup @ DESY May.2023

Hitmap

- 每个平面有3/4/1/6/10个像素被屏蔽。

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● Plane3的命中率并不像预期的那样好,这个平面产生的数据比其他平面多,可以看到"马赛克",暂不展示5层重建结果

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- 通常情况下, Plane 0/1/3/4被设置为望远镜平面, 平面2被设置为DUT(被测设备)
- 由于Plane 3的"马赛克"问题还没有完全清楚,暂时排除Plane3做数据分析
- Alignment发现在束流方向和芯片的X方向之间有一个1度的倾斜角,导致每层x方向偏移约 450um, Plane0/4会偏移一个Sector以上宽度

Plane3 is not adopted in resolution and efficiency analysis for now.

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The region of interest (**ROI**)

Sec 0 Sec 1

ITHR vs Cluster Size

- \bullet
- 阈值从330pA增加到800pA, Cluster Size大小从6.0减少到2.8

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Threshold

阈值扫描只扫描DUT,即Plane2,其它望远镜层阈值为默认阈值500pA(220e⁻)

DUT Spatial Resolution

 $\sigma_x(tel) = 4.0 \ um, \sigma_v(tel) = 3.3 \ um$ $\sigma_x(DUT) = 6.8 \ um, \sigma_v(DUT) = 5.6 \ um$

ITHR=300pA(~150e), DUT在x和y方向的残差分别为6.8um和6.4um, 分辨率变差原因: 1. 望远镜拓扑结构变差 2. Sector间 边界影响

探测效率~99.38%

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Residuals and Efficiency

无Cut情况下,随着ITHR的增加(从~150e-到~300e-): X方向的残差sigma从8.0增加至9.5 Y方向上没有明显的趋势,原因未知 探测效率从99%降低到84%

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800 ITHR [pA]

- 重建算法
- 2.通过束流测试得到JadePix-3空间分辨、探测效率指标:
 - ▶ 在列和行方向的空间分辨率达到5.4um 和4.1um
 - ▶ 探测效率可达~99.3%

- 1. 5层束流望远镜测试数据完全分析
- 2. 将JadePix-3束流望远镜应用与JadePix-4/CPV4-3D性能测试中

致谢

- ▶ 非常感谢TaichuPix小组提供3次束流测试机会
- ▶ 感谢DESY和BSRF对我们实验的支持

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1. 基本实现JadePix-3束流望远镜研究其中两个初衷:通用多芯片读出系统、离线

谢谢聆听!

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Alignment

Pre-alignment method:

• Using the mean offset values in X and Y as the required translational shift to update the geometry. Alignment method:

Perform translational alignment and rotational alignment using tracks

• Refit all of the tracks and the minimize the χ^2 of tracks

The mean value of χ^2 distribution will drop very significantly after alignment. (191.5 –> 19.5 –> 2.5)

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Alignment

The alignment procedure includes 2 steps:

1. Align the telescope plane, and ignore the DUT

- Pre-alignment (x, y geometry)
- Fine alignment (x, y geometry and x, y, z orientation)

2. Align the DUT, and freeze telescope geometry

- Pre-alignment (x, y geometry)
- Fine alignment (x, y geometry and x, y, z orientation)
- multiple scattering.
- Hit uncertainties are taken into account.
- The χ^2 is defined by the resolution weighted sum of residuals r_p in global coordinates:

While tracking, the path of the particle is described as a straight line, **ignoring the effect of**

$$\sum_{p=0}^{N} \frac{r_{p_x}^2}{\sigma_{p_x}^2} + \frac{r_{p_y}^2}{\sigma_{p_y}^2}$$

Spatial Resolution

Results from the EUDET telescope with high resolution planes, <u>https://doi.org/10.1016/j.nima.2010.03.015</u>

- resolution width (σ_{tel}) using equation (1):
- resolution, using equations (2) (3):

$$\sigma_{meas}^2 = k \sigma_{plane}^2$$
 (2),

telescope plane and of the overall telescope can be derived directly from measured residual width:

$$\sigma_{plane}^2 = \frac{\sigma_{meas}^2}{1+k}$$
(4)

The single plane resolution (σ_{DUT}) can be obtained from the measured residual width (σ_{meas}) and the telescope

$$\sigma_{meas}^2 = \sigma_{DUT}^2 + \sigma_{tel}^2$$
(1)

The telescope resolution can be determined assuming that the reference planes all have the same intrinsic

$$k = \frac{\sum_{i}^{N} z_{i}^{2}}{N \sum_{i}^{N} z_{i}^{2} - (\sum_{i}^{N} z_{i})^{2}}$$
(3)

If the device under test is of the same type of the reference planes, the intrinsic resolution of the single

and
$$\sigma_{tel}^2 = \frac{k}{1+k} \sigma_{meas}^2$$
 (5)

